N ovel P ressure Induced Structural P hase T ransition in A gSbTe₂

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We report a novel high pressure structural sequence for the functionally graded them oelectric, narrow band gap sem iconductor $AgSbTe_2$, using angle dispersive x-ray di raction in a diam ond anvil cell with synchrotron radiation at room tem perature. The com pound undergoes a B1 to B2 transition; the transition proceeds through an interm ediate am orphous phase found between 17-26 GPa that is quenchable down to am bient conditions. The pressure induced structural transition observed in this com pound is the rst of its type reported in this temary cubic fam ily, and it is new for the B1-B2 transition pathway reported to date. Density Functional Theory (DFT) calculations perform ed for the B1 and B2 phases are in good agreem ent with the experimental results.

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Ternary sem iconductors with a general form ula ABX₂ (A = Cu₁Ag; B = In₁Ga₁Sb; X = S₁Se₁Te) with chalcopyrite or rock salt structure are widely used for important technical and device applications. These com pounds are found to be excellent candidates for the fabrication of optical frequency converters in solid state laser system s, photovoltaic devices and developm ent of solar cells.^{1,2,3} W hile the Cu based chalcopyrites are mainly studied in connection with their photovoltaic applications, the Ag compounds nd importance in therm oelectric, optical phase change and frequency conversion applications.^{4,5} Cubic AgSbTe₂ com pounds with Pb doping have been recently shown to be excellent therm oelectric materials with high gures of merit, and are considered prom ising candidates for future energy production from heat sources.⁶ AgSbTe₂ with In and V doping undergo, rapid crystalline - am orphous phase transitions on local melting; a property that is used widely to write and rewrite Compact Disks (CD) and Digital Versatile Disks (DVD).^{7,8} In comparison with the classical GeSbTe phase change memory alloy, AgV InSbTe is reported to have better erasability and cyclablity in m em ory switching .7,8,9,10 The phase changes in these materials are tem perature driven, and the previous studies focus mainly on doped thin Im s of AgSbTę. To our know ledge, no detailed structural reports are available for the host com pound AgSbTe2, under di erent tem perature or pressure conditions.

A gSbTe₂ is isostructural to the rocksalt type II-VI chalcogenides. A s the rock salt structure of m ost of the II-VI compounds is sensitive to pressure, changing from B1 to B2,^{11,12} one may expect A gSbTe₂ to display a sim – ilar crystallographic transition under pressure. The aim of the present study is to investigate A gSbTe₂ under pressure to explore the structural sim ilarities with its binary analogues. In this paper, we present experimental evidence, for the rst time, of a pressure induced structural transition from B1 (crystalline) to B2 (crystalline) with an interm ediate am orphous state. This is a new pathway for this structural sequence and is unique in the ABX₂

fam ily. This nding may open up new directions in the search for sim ilar compounds of scienti c and technological importance. A lso, it forces us to develop theoretical models that can explain the pressure induced am orphization.

AgSbTe₂ has been prepared by a conventional solid state reaction m ethod. Stoichom etric am ounts of starting material were melted in a Bridgman furnace at 873 K for 24 hours, then cooled to am bient conditions. The reacted m ixture was checked with x-ray di raction (XRD) and found to be single phase. In each high pressure run, a small piece of sample cut from a pellet along with a ruby chip was loaded with silicone oil in a stainless steel gaskethaving a 180 m hole between 500 m culet diam eter diam onds in a diam ond anvil cell. X RD experiments were performed using a rotating anode x-ray generator (Rigaku) operating with an M o target for run 1, and synchrotron x-rays with beam size 20 20 m at HPCAT, Sector 16 IDB at the Advanced Photon Source for runs 2 and 3. The XRD patterns were collected using a MAR im aging plate (300 300 mm²) camera with 100 100 m² pixel dimension for 10-20 s. The images were integrated using FIT 2D program $m e_r^{13}$ and structural renem ents were carried out by Rietveld method with RI-ETICA (LHPM) software package.¹⁴ The pressure at the sam ple site has been estim ated using the standard ruby uorescence technique and the new ly proposed ruby scale of H olzapfel.15

At am bient conditions, $AgSbTe_2$ crystallizes in the rocksalt structure (Fm 3m symmetry); the metal atom s located at N a sites at (0;0;0) and the Te atom s occupy the Cl sites at (0:5;0:5;0:5). The di raction peaks at am bient pressure can clearly be indexed to an fice lattice with cell parameter $a = 6:0780(1) A \cdot ^{16}$ U pon compression, the di raction lines remain sharp and system atically shift with pressure as shown in Fig. 1. From the remements, a decreases at a rate of 0.024 A/GPa, while the the Ag/Sb-Te distance decreases at 0.0118 A/GPa. The sm all variation of the Ag/Sb-Te distance relative to a indicates the rigid bonding of the metal-chalcogen atom s.

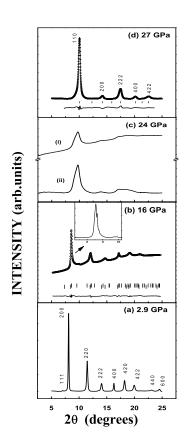


FIG. 1: Representative x-ray di raction patterns with increasing pressure. The inset in (b) shows the splitting observed in the (200) line before am orphization. The Rietveld re nem ent for the Cm cm phase is also shown. The renem ent residual is $R_{\rm W\,p} = 1.473$. D i raction patterns at 24 G Pa with back ground (i) and after back ground substraction (ii) are shown in (c). The Rietveld plot for the x-ray di raction pattern obtained at 27 G Pa (d) shows the B2 structure.

The rocksalt phase is stable up to 15 GPa sim ilar to the behavior of the isostructural compound AgSbSe₂ under pressure.¹⁷ At 16 GPa, we have noticed splitting of (200) and (420) peaks (inset of Fig. 1 (b)) with broadening of other di raction lines. These features clearly indicate the onset of a structural transform ation. To our suprise, at 17 GPa, we observed a sudden drop in the intensity of all di raction lines, leaving a halo peak located ar ound 2 v 9.5 with a signi cant broad background. The features observed in the XRD pattern at this pressure resembled the spectra typical for am orphous com pounds. The am orphous phase persists up to 25 GPa as shown in Fig. 1 (c).

The current models explaining the reconstructive phase changes of B1 structure are based upon either the Buergers mechanism (i.e. the strain model) or the one emphasized by W atanabe et al. based on displacive transitions.^{18,19,20,21} Recently Toledano et al. studied di erent sequences for the pressure driven transitions from the B1 phase due to the coupling of the tensile

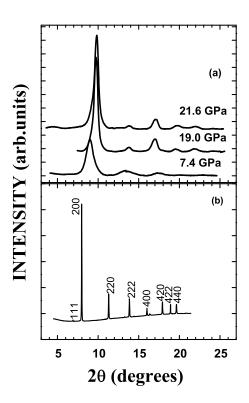


FIG.2: (a) Sequence of x-ray di raction patterns collected at di erent pressures while decom pression. (b) R eappearance of di raction lines corresponding to the B1 phase after heating the DAC for 100 C for 1 hr at am bient pressure.

and shear strains,²² and they suggest possible interm ediate orthorhom bic B 33 (Cm cm) and B 16 (Pbnm) structures. Previous high pressure structural studies on II-VI chalcogenides have shown transformation of NaCl phase to an interm ediate orthorhom bic phase (Cm cm or Pbnm),^{23,24,25} we have examined the XRD pattern obtained at 16 GPa for similar types of distortions with Cm cm and Pbnm structures. Both Pbnm and Cm cm structures were considered during the Rietveld re nement, and a reliable t has been obtained using the Cm cm space group, with the Ag/Sb atom s located at 4a sites (0;0;0) and Te atom s occupying the 8d sites (0:75;0:25;0:5). The cell parameters obtained for the orthorhom bic phase are a = 3:7974(3) A, b = 4:238(4)A and c = 5.6358(1) A.W e nd no considerable volum e change between the B1 and orthorhom bic phases as the two phases are found to coexist and the transition is continuous. Our results unambiguously show the distortions are related to the Cm cm space group, and the features of AgSbTe2 before an orphization indicate the distortions are sim ilar to those observed in lead, calcium, and cadmium chalcogenides during the B1-B2 transition.^{23,24,25,26} These results closely agree with the earlier theoretical models explaining the rearrangem ent of atom s displaced between the layers during the B1-B2 transitions.

W hile com paring our results with sim ilar com pounds

exhibiting pressure induced am orphization, it is interesting to note that the corner linked tetrahedral -quartz and isostructural compounds undergo transitions to a m etastable polym orphic state before am orphization sim ilar to AgSbTe₂. In their molecular dynamics simulations based on enthalpy considerations, Chaplot and Sikka,²⁷ and later, N and hiniG arg and Surinder Sharm a, 28 show ed that above 12 GPa, the Cm cm phase is favorable. The experimental observation of the disordered Cm cm phase before an orphization in $-FePO_4$ by Pasternak et al,²⁹ and in $GaPO_4$ by other groups, con m this scenario.³⁰ In conjunction with the above, the orthorhom bic Cm cm phase is energetically favoured in AgSbTe₂ while approaching from B1 to a denser phase. Since simultaneous occurrence of crystalline and am orphous phases has been seen in FePO4, and also partial am orphization is reported in $C \circ (O H)_2$ by N guyen et al,³¹ we have exam ined the relative abundance of the crystalline phase if any, in the amorphous region. As seen in Fig. 1(c), there are no signi cant crystalline features identi ed, only a major halo peak. This fact elim inates the possibility of coexisting crystalline and am orphous phases. Interestingly, at 26 GPa, the di raction lines started to reappear, show ing the transform ation of the am orphous state to a new crystalline phase. The observed x-ray di raction pattem showed few peaks, and the re nem ent clearly indicated the existence of a C sC l phase with cell param eter a = 3:4500(3) A. The CsClphase was found to be stable up to 30 GPa as shown in the Fig. 1 (d).

The observation of Cm cm orthorhom bic distortions and an interm ediate am orphous phase, while undergoing transition from the six fold coordinated B1 phase to eight fold coordinated B2 phase, clearly indicates a coordination frustration taking place in A gSbTe2 due to the defect cubic structure and movem ent of Te atom s under pressure. This fact is consistent with the tem perature driven am orphous state, observed in the doped fam ily, where doping may increase internal defects, so that am orphization can be easily induced by tem perature. Even though the structural transitions in AgSbTe₂ resemble SnI₄ $_{1}^{32}$ the mechanism of amorphization is rather di erent. In the latter compound, molecular dissociation sim ilar to B aA s is observed where a kinetically frustrated solid state am orphization is due to a change from fourfold to sixfold coordination.33

Selected di raction patterns during decom pression are shown in the upper panel of Fig. 2. The crystalline peaks corresponding to the C sCl phase rem ained down to 12 G P a. Below 12 G P a, we observed broadening of the peaks, and transform ation to am orphous state, showing hysteresis in the transition from C sCl phase to am orphous phase. The am orphous features rem ained even after releasing the pressure in the D A C, with a partial crystallization to Bl phase. The D A C was heated in an oven for 100 C for 1 hr, and di raction patterns were taken. Suprisingly, sharp di raction lines corresponding to B1 phase reappeared as shown in the bottom panel of Fig. 2, and the B1 phase is retained with a lattice constant

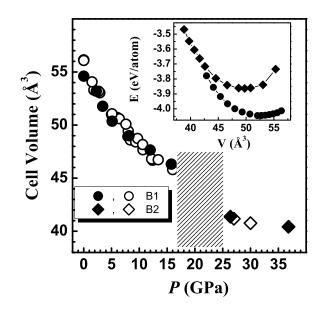


FIG. 3: P V data for AgSbTe₂. The open symbols (circles denote B1 and diam onds B2) are the experim ental data and the solid symbols represent the theoretical calculations for both phases. The am orphous phase is observed in the shaded region. (Inset) B inding energy curves for the B1 and B2 phases of AgSbTe₂.

consistent with the initial am bient pressure value. These facts suggest that the pressure induced am orphous state in A gSbTe₂ is reversible, and therm all annealing supplies the energy to overcome the am orphous-crystalline energy barrier. This activates the recrystallization process back to the B1 phase identical to that observed in A PO_4 and KH₂PO₄ (KDP).^{34,35}

In order to understand the stability of B1 and B2 phases observed experimentally, we have performed density functional theoretical (DFT) calculations using the FH 198M D code,^{36,37} local density approximation (LDA),³⁸ and norm conserving pseudo potentials. Troullier-M artins type pseudopotentials were generated for Ag, Sb, and Te atom s and extensive convergence tests were carried out in order to check the dependency of the number of k-points and plane waves.³⁹ The electronic wave-functions were expanded in plane-wave basis set with an energy cuto of 71 Ry. Energy convergence was achieved with an accuracy of 10⁴ eV. The k-point integration was performed with mesh points corresponding to 8 k-points in the Brillouin zone.

B inding energy curves show that the B1 phase is energetically favorable by 0.18 eV/atom relative to the B2 phase at am bient conditions as shown in Fig. 3. The calculated lattice constant of the B1 phase is 5.93 A. This is in excellent agreem ent with the experim ental value of 6.08 A and com pares favorably to other calculated values of 5.676 A and 6.29 A by M. Luo et al.⁴⁰ and R. D etem ple et al.⁵ respectively. C alculations perform ed for the B2 phase reveal that it is favoured around 26 GPa. M ore detailed calculations to understand the interm ediate phases are in progress.

A t of the experimental P V data for the B1 phase, with the second order B irch-M umaghan equation of state, yielded a bulk m odulus of $B_0 = 45$ (2) G P a with $B_0^0 = 4.8$. Even though the lattice constant is underestimated 2% compared to the experimental value, the bulk m odulus 44.5 G P a, obtained theoretically, is in good agreement with the experimental value, when compared with the previous reports. For direct comparison of the equation of state, the theoretical volume is scaled to the experimental values as shown in Fig. 3.

In conclusion, we have dem onstrated a new structural sequence in the functionally graded material $AgSbTe_2$, which exhibits a B1 to B2 transition with an interm ediate am orphous phase. The results of the ab initio simulations strongly support the pressure induced structural

transitions.

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